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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination LAIHO ET AL. | |
| | | Examiner Tu X. Nguyen | Art Unit 2618 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-6,539,237 B1 | 03-2003 | Sayers et al. | 455/555 |
| * | B | US-5,070,329 | 12-1991 | Jasinaki, Leon | 340/7.27 |
| * | C | US-2003/0110233 A1 | 06-2003 | Prall, Scott D. | 709/213 |
| * | D | US-2001/0023184 | 09-2001 | Kalveram et al. | 455/426 |
| * | E | US-6,456,845 | 09-2002 | Drum et al. | 455/424 |
| * | F | US-6,298,225 B1 | 10-2001 | Tat et al. | 455/220 |
| | G | US-6,876,835 | 04-2005 | Marko et al. | 455/3.06 |
| | H | US-6,674,994 | 01-2004 | Fell et al. | 455/3.06 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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